



<b>Search Notes</b> 	<b>Application/Control No.</b> 10743768	<b>Applicant(s)/Patent Under Reexamination</b> YO, SEIJI
	<b>Examiner</b> DINH, DUC Q	<b>Art Unit</b> 2629

<b>SEARCHED</b>			
<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
345	87/102,690-699	07/22/06	

<b>SEARCH NOTES</b>		
<b>Search Notes</b>	<b>Date</b>	<b>Examiner</b>
EAST SEARCH		
INTERFERENCE SEARCH		
INVENTOR NAME SEARCH	11/20/2006	DD

<b>INTERFERENCE SEARCH</b>			
<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
349	108,48,84,144,83	11/20/06	DD

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